

Analytical Reference Materials International

Certificate of Analysis Certified Reference Material



Grade: **Haynes 556 / UNS R30556**

Part Number (Q.A. NO.): **IARM 100B**

Certification Date: **11/23/1999**

Certificate No.: **100B-11231999-IARM-F**

Revision Date: **11/06/2003**

Interpretation of Data

1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community.
2. Any data reported and enclosed by a **parentheses ()** is a **"best estimate"** and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
3. The "Inter-laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets []** indicates **further testing is in process**.
4. The "**± Confidence Interval at 95%**" is enclosed by a **parentheses ()** below the individual element's concentration.

IMPORTANT: A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

<u>Aluminum</u> 0.31 (0.01)	<u>Boron</u> (0.003)	<u>Carbon</u> 0.100 (0.001)	<u>Cobalt</u> 18.03 (0.08)	<u>Chromium</u> 22.32 (0.09)	<u>Copper</u> 0.049 (0.004)	<u>Manganese</u> 1.07 (0.01)
<u>Molybdenum</u> 3.13 (0.02)	<u>Nitrogen</u> 0.132 (0.002)	<u>Niobium</u> 0.130 (0.006)	<u>Nickel</u> 21.16 (0.08)	<u>Oxygen</u> 0.0016 (0.0004)	<u>Phosphorus</u> 0.010 (0.001)	<u>Sulfur</u> 0.0006 (0.0003)
<u>Silicon</u> 0.400 (0.008)	<u>Tantalum</u> 0.55 (0.04)	<u>Tin</u> <0.005	<u>Titanium</u> 0.005 (0.002)	<u>Vanadium</u> 0.043 (0.001)	<u>Tungsten</u> 2.48 (0.03)	<u>Zirconium</u> 0.011 (0.002)

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

AK Steel, Butler Works - Butler, PA
Allegheny Ludlum Corp. - Brackenridge, PA
Anderson Laboratories, Inc. - Greendale, WI
Chicago Spectro Service Laboratories - Chicago, IL
Jorgensen Forge Corp. - Seattle, WA
Lockheed Martin Astronautics - Littleton, CO

Allegheny Ludlum Corp. - Brackenridge, PA
Allvac Lockport - Lockport, NY
Carpenter Technology Corporation - Reading, PA
Conam Inspection - Gary, IN
Laboratory Testing, Inc. - Hatfield, PA
Wisconsin Centrifugal, Inc. - Waukesha, WI

Traceability: All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs and RMs applicable to the material covered by this certificate are: NIST 1226, 1261A, 1262A, 1265A, C1151, C1152, C1153, C1154, 1155, 1193, 1194, 1195, 1230, C2400, JSS 650, 651, 652, 653, 654, 655, BCS331, 332, 333, 334, 335, 336, 337, 338, ARMCO 8709, 8710, 8711, 8712, MBH14933, 14934, 14935, BSC 401/1, 402/1, 403/1, 404/1, 405/1, 406/1, 407/1, 408/1, 409/1, 410/1, IARM 1B, 2B, 4B, 5B, 9B, 11B, 152A, 157A162A, 163A, 205A, 27B, 28B, 29B, 30B, 31B, 32B, 33B, 34B, 35B, 36B, 48B, 49B, 155A, 156A, 164A, 165A, 166A, 167A, 168A, 169A, 170A, 171A, 172A, BS 162, IARM 100A, 60A, NIST 1187, 1208, NIST 349, 121D, 868, 133A, 1091A, NIST 136E, 897, 898, 865, BS 162, NIST 341, 73C, 346A, LECO 501-679, 501-553, AK B-85, IARM 100A, LECO 501-501, AR 663, NIST 1187, AR872, LECO 502-016, NIST 443, 444, IARM 100A, 99A, BS 162, LECO 501-676, 501-553, IARM 100A, 27B, NIST 362, LECO 502-072, 501-647, IS 00117, IS 00118, IS 00119, IS 00120, IS 00121, IS 00158, IARM 100a, BS 162, CT 175, 2720, LECO 501-675, AR 663, BS 162, LECO 502-016, 501-550

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

See Reverse Side for Statistical Data and Additional Information Regarding this Material.

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 11/06/2003.

100B	Al	B	C	Co	Cr	Cu	Fe	Mg	Mn	Mo	N	Nb	Ni	O	P	S	Si
1	0.3275	<0.002	0.0991	17.99	22.03	0.044	30.68	<0.0001	1.06	3.09	0.131	0.1244	21.02	0.0014	0.011	0.0003	0.402
2	0.29	0.0011	0.099	17.96	22.33	0.055	30.13	0.0131	1.041	3.112	0.1325	0.1392	21.246	0.00197	0.0071	0.0002	0.4136
3	0.2966	0.0048	0.1012	18.175	22.379	0.0423	29.40	0.0004	1.0707	3.181	0.1357	0.123	21.26	0.0011	0.006	0.0010	0.3869
4	0.312	0.0018	0.09806	17.933	22.38	0.047	30.70	0.00639	1.10	3.164	0.134	0.134	21.07	0.0012	0.0074	0.00037	0.397
5	0.320	0.00362	0.100	18.084	22.409	0.056	30.97	<0.001	1.091	3.117	0.1360	0.137	21.039	0.0021	0.0116	0.0006	0.401
6	0.314	0.001	0.101	18.057	22.127	0.054	30.153		1.066	3.155	0.1265	0.124	21.137	0.0019	0.0131	0.0013	0.4178
7	0.32		0.0982	18.00	22.142	0.047	30.07		1.053	3.10	0.1289	0.130	21.31	0.0016	0.010	0.0004	0.401
8			0.101		22.411	0.047			1.088	3.11	0.130		21.106		0.0077	0.0005	0.409
9					22.53				1.0987	3.16	0.132		21.17		0.0092		0.386
10					22.52				1.10	3.127	0.1315		21.29		0.0131		0.388
11					22.222				1.082	3.12					0.0112		
12					22.37				1.08	3.15					0.010		
13					22.28				1.04								
Mean	0.3114	0.0025	0.0997	18.0284	22.3177	0.0490	30.3004	0.0066	1.0746	3.1322	0.1318	0.1302	21.1648	0.0016	0.0098	0.0006	0.4002
STDV.	0.0135	0.0017	0.0013	0.0831	0.1511	0.0052	0.5271	0.0064	0.0214	0.0288	0.0030	0.0067	0.1067	0.0004	0.0024	0.0004	0.0111
Certified	0.31	(0.003)	0.100	18.03	22.32	0.049	(30.1)	<0.01	1.07	3.13	0.132	0.130	21.16	0.0016	0.010	0.0006	0.400
95% C.I.	0.01		0.001	0.08	0.09	0.004			0.01	0.02	0.002	0.006	0.08	0.0004	0.001	0.0003	0.008
Methods	X,I,O		O,I	X,I	X,W,O	X,I,O	X,O	X,D,I	X,I,O	X,I,O	F,O	X,I,O	X,W,O	F	X,I,O	C,X,O	X,I,O

LEGEND: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G = GDMS

100B	Ta	Ti	V	W	Zr	Ag	As	Bi	Ca	H	La	Pb	Sb	Se	Sn	Y	Zn
1	0.64	0.005	0.0441	2.48	0.0102	<0.0001	0.0017	<0.0001	0.1086		0.008	0.0019	0.0007	<0.0001	0.1839		
2	0.48	0.0039	0.0424	2.439	0.0086		0.0016	<0.0001			0.007	0.00005	<0.0001	0.00003	0.001		
3	0.5514	0.002	0.043	2.5319	0.0080			<0.01	<0.001				0.01008		<0.01	0.0420	
4	0.536	0.0111	0.043	2.46	0.013							0.0001			0.0020		
5	0.55	0.0041	0.044	2.551	0.013										0.001		
6	0.56	0.002	0.042	2.575	0.011										0.0050		
7	0.551	0.0085		2.402											0.0022		
8	0.501	0.0085		2.46													
9		0.002		2.47													
10		0.0025		2.43													
11				2.436													
12				2.439													
13				2.53													
Mean	0.5462	0.0050	0.0431	2.4772	0.0106	#DIV/0!	0.0017	#DIV/0!	0.1086	#DIV/0!	0.0075	0.0030	0.0007	0.0000	0.0339	#DIV/0!	#DIV/0!
STDV.	0.0472	0.0033	0.0008	0.0532	0.0021	#DIV/0!	0.0001	#DIV/0!	#DIV/0!	#DIV/0!	0.0007	0.0048	#DIV/0!	#DIV/0!	0.0678	#DIV/0!	#DIV/0!
Certified	0.55	0.005	0.043	2.48	0.011										<0.005		
95% C.I.	0.04	0.002	0.001	0.03	0.002												
Methods	X,I,O	X,I,O	X,I,O	X,I,O	X,D,I										X,A,I,O		

LEGEND: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G = GDMS

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1981-(E) list the following:

Certifying Body: A technically competent body (organization or firm, public or private) that issues a Reference Material Certificate. The only generally accepted certifying body in the United States is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD.


Reference Material (RM): A material or substance with one or more properties which are sufficiently well established to be used for calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

Certified Reference Material (CRM): A reference material with one or more properties whose values are certified by a technically valid procedure accompanied by or traceable to a certificate or other documentation, which is issued by a Certifying Body.

Inter-Laboratory Analysis Program (ILAP): Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

Methods of Analysis: In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen and Oxygen are the result of combustion instrument procedures.

Selection of Materials: A "batch" or "series" is defined as a single bar of one continuous length. The majority of materials are in wrought condition. Other methods of manufacture are utilized as a last resort, only in the case of those materials being unavailable in wrought condition. "Batch" samples are taken by removing a one-inch cross section for every thirteen inches of total length from the entire bar. Twenty-five percent of the one inch cross section is converted to chips for analysis by classical wet chemistry, ICP, AA, and combustion procedures and seventy-five percent remains in a solid disk form for OES and X-Ray analysis where applicable. Each member of the ILAP is furnished both a solid sample and the corresponding supply of chips from a specific location on the batch bar. This massive sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data.

Certified by: 
 William D. Britt, President/General Manager
 Analytical Reference Materials International

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